Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/002,318	MAGEE, DAVID PATRICK
Examiner	Art Unit
Krista M. Flanagan	2631

	SEARCHED					
Class	Subclass	Date	Examiner			
375	224 226 344 345 371 375	1/24/2005	KMF			
	<u>. </u>					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (Bocure)	1/24/2005	KMF		
Inventorship EAST (Bocure)	1/28/2005	KMF		
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